


<b>Search Notes</b>  	<b>Application/Control No.</b>  10816460	<b>Applicant(s)/Patent Under Reexamination</b>  SADRI ET AL.
	<b>Examiner</b>  Veillard, Jacques	<b>Art Unit</b>  2165

SEARCHED			
Class	Subclass	Date	Examiner
707	1 - 10, 100 - 102, 104.1 with limited keywords (Updated 11/20/2007)	02/21/2007	J.V
709	203, 217 - 219, 224, 245 with limited keywords (Updated 11/20/2007)	02/21/2007	J.V
715	505, 513, 762, 968 with limited keywords (Updated 11/20/2007)	2/21/2007	J.V

SEARCH NOTES		
Search Notes	Date	Examiner
EIC Plus Database Search	7/21/2007	J.V
West Electronic Database Search Using limited keywords (Updated 11/20/2007)	2/21/2007	J.V
Consulted with Wassum P.E AU 2167	8/2/2007	J.V
Consulted with Jeff G. SPE AU 2165	8/2/2007	J.V

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
707	3, 5, 10 Using limited keywords	11/20/2007	J.V
709	219, 224 Using limited keywords	11/20/2007	J.V